

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10532748	PAVON ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Cehic, Kenan	2616	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	346,449,395.4,343,344,230	12/5/2007	KC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventorship search	12/5/2007	KC
Consulted with SPE Kwang Yao	12/5/2007	KC
IEEEExplore	12/5/2007	KC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>